

Laboratory **WW Defsys Pvt. Ltd., R1 & R2, Site V, Kasna Industrial Area, Greater Noida, Uttar Pradesh**

Accreditation Standard **ISO/IEC 17025: 2005**

Certificate Number **TC-5414**

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Validity **31.03.2017 to 30.03.2019**

Last Amended on --

Sl.	Product / Material of Test	Specific Test Performed	Test Method Specification against which tests are performed	Range of Testing / Limits of Detection
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ELECTRONICS TESTING

I.	ENVIRONMENTAL TEST FACILITY			
1.	Opto - Electronics Components & Equipment	Cold (low Temperature)	IS 10236 Pt. 3 JSS 55555:2000/2012 (Test No. 20) MIL 810G (502.5 , Pro I & II)	Qualitative (-) 10°C to Ambient
		Dry Heat (High Temperature)	IS 10236 Pt.2 JSS 55555:2000/2012 (Test No.17) MIL 810G (502.5,Pro I & II)	Qualitative Ambient to 100°C
		Humidity (Damp Heat)	IS 10236 Pt. 4 JSS 55555:2000/2012 (Test No. 10) MIL 810G (507.5 , Pro III) IS 9000 (Part 4, Section 5 RA on 2007)	25 °C to 40°C Humidity Range 95%
		Drop Test	IS 10236(Pt. 15) -1986, RA on 1998 JSS 55555:2000 Revision No.2 (Test No. 13) IS 9000 (Part 7/ Sec 3) 1979	10 mm to 1000 mm

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